



Atty. Dkt. No.	M#	Client Ref.
081468	0305376	P-0362.010-US

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Applicant: VAN BILSEN et al.	
Appin. No.: 10/665,404	
Filing Date: September 22, 2003	
Examiner: JOHN R. LEE	Group Art Unit: 2878

Date: April 27, 2007 Page 1 of 1

U.S. PATENT DOCUMENTS

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
/JL/	AR 5,721,607 A	02/24/1998	Ota			
	BR					
	CR					
	DR					
	ER					
	FR					
	GR					
	HR					
	IR					
	JR					
	KR					

FOREIGN PATENT DOCUMENTS

	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract		Translation Readily Available	
					Enclosed	No	Enclose	No
	LR							
	MR							
	NR							
	OR							
	PR							
	QR							
	RR							
	SR							
	TR							
	UR							

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

VR				
WR				
XR				
YR				
ZR				
AAR				

Examiner /John Lee/ (05/28/2007) Date Considered:

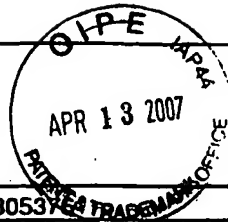
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

FORM PTO-1449 (modified)
To: U.S. Department of Commerce
(PW FORM PAT-1449)
Patent and Trademark Office



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Group Art Unit: 2881

Date: February 10, 2004

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JL	AR	4,037,969	07/1977	FELDMAN et al.			
	BR	4,236,805	04/1982	FELDMAN et al.			
	CR	4,251,160	02/1981	BOUWHUIS et al.			
	DR	4,355,892	10/1982	MAYER et al.			
	ER	4,398,824	08/1983	FELDMAN et al.			
	FR	4,514,858	04/1985	NOVAK			
	GR	4,540,277	09/1985	MAYER et al.			
	HR	4,614,432	09/1986	KUNIYOSHI et al.			
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	JR	4,710,026	12/1987	MAGOME et al.			
	KR	4,748,333	05/1988	MIZUTANI et al.			
	LR	4,778,275	10/1988	VAN DEN BRINK et al.			
	MR	4,814,829	03/1989	KOSUGI et al.			
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	RR	4,952,970	08/1990	SUZUKI et al.			
	SR	5,100,237	03/1992	WITTEKOEK et al.			
	TR	5,114,236	05/1992	MATSUGU et al.			
	UR	5,118,953	06/1992	OTA et al.			

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							Enclosed	No	Enclose	No
JL	VR	11-329914	11/1999	Japan	SAKO TAKASHI		X			X
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	XR									
	YR									

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/JL/	ZR	Markle, D. A., "Submicron 1:1 Optical Lithography", Semi-conductor International, pp. 173-142, May 1986.	X			
	AAR					
	BBR					
	CCR					

Examiner /John Lee/ (02/18/2007)

Date Considered:

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PAT-1449 12/98

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Group Art Unit: 2881

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	BR	5,151,754	09/1992	ISHIBASHI et al.			
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	MR	5,801,390	09/1998	SHIRAISHI			
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